

Vishay Siliconix

N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
40	0.0045 at V _{GS} = 10 V	27.2	29 nC			
40	0.006 at $V_{GS} = 4.5 \text{ V}$	23.5	29110			

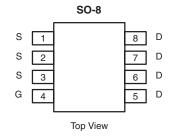
FEATURES

- · Halogen-free
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested

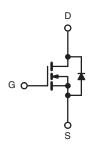


APPLICATIONS

• DC/DC Conversion



Ordering Information: Si4122DY-T1-GE3 (Lead (Pb)-free and Halogen-free)



N-Channel MOSFET

Parameter Drain-Source Voltage Gate-Source Voltage		Symbol	Limit	Unit	
		V _{DS}	40 ± 25	v	
		V_{GS}			
	T _C = 25 °C		27.2		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	I _D	20.1		
Continuous Diain Curient (1) = 150 C)	T _A = 25 °C	1 'D	19.2 ^{b, c}		
	T _A = 70 °C		15.3 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	70	A	
Operation and Operation Divide Operated	T _C = 25 °C	I.	5.4		
Continuous Source-Drain Diode Current	T _A = 25 °C	ls –	2.7 ^{b, c}		
Single Pulse Avalanche Current	I = 0.1 mH	I _{AS}	40		
Avalanche Energy L = 0.1 mH		E _{AS}	80	mJ	
	T _C = 25 °C		6.0		
Maximum Dawar Dissination	T _C = 70 °C	P _D	3.3	W	
Maximum Power Dissipation	T _A = 25 °C		3.0 ^{b, c}	VV	
	T _A = 70 °C		1.9 ^{b, c}		
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R_{thJA}	33	42	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	16	21	S/VV		

- a. Based on T_C = 25 °C. b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 85 $^{\circ}\text{C/W}.$

Si4122DY

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40			٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 0504		43		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I _D = 250 μA		- 6.0		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.2		2.5	٧
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 100	nA
Zana Oaka Walkana Busin Oamani		V _{DS} = 40 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α
		V _{GS} = 10 V, I _D = 15 A		0.0036	0.0045	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A			0.006	Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		65		S
Dynamic ^b				L	l	
Input Capacitance	C _{iss}			4200		
Output Capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		475		pF
Reverse Transfer Capacitance	C _{rss}	30 0.0		225		
		V _{DS} = 20 V, V _{GS} = 10 V, I _D = 10 A		62	95	
Total Gate Charge	Q _g			29	44	_
Gate-Source Charge	Q_{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		12		nC
Gate-Drain Charge	Q_{gd}			9		
Gate Resistance	R_g	f = 1 MHz	0.2	1.0	2.0	Ω
Turn-On Delay Time	t _{d(on)}			42	70	
Rise Time	t _r	$V_{DD} = 20 \text{ V}, R_{L} = 2 \Omega$		34	60	ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		45	75	
Fall Time	t _f			28	45	
Turn-On Delay Time	t _{d(on)}			14	25	
Rise Time	t _r	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		35	60	
Fall Time	t _f			9	18	
Drain-Source Body Diode Characteristi	cs				•	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			5.4	
Pulse Diode Forward Current ^a	I _{SM}				70	Α
Body Diode Voltage	V _{SD}	I _S = 3 A		0.72	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			31	50	ns
Body Diode Reverse Recovery Charge	Q _{rr}	1		31	50	nC
Reverse Recovery Fall Time	t _a	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		18		
Reverse Recovery Rise Time t _b		†		13		ns

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

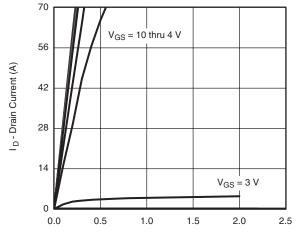
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$

b. Guaranteed by design, not subject to production testing.



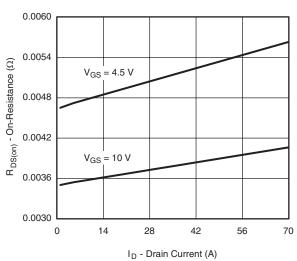
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

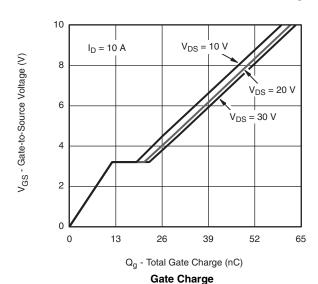


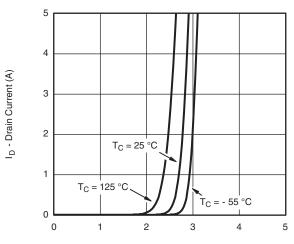
V_{DS} - Drain-to-Source Voltage (V)





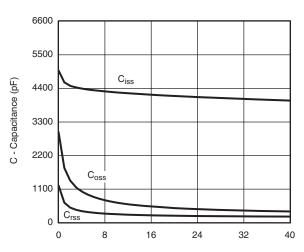
On-Resistance vs. Drain Current and Gate Voltage





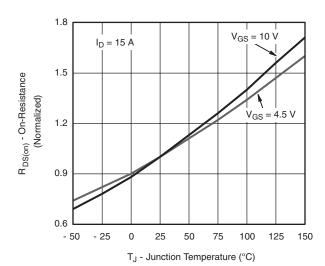
V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics



V_{DS} - Drain-to-Source Voltage (V)

Capacitance



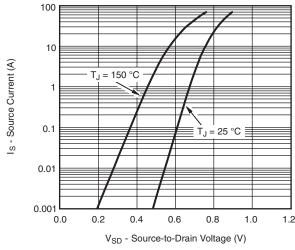
On-Resistance vs. Junction Temperature

Si4122DY

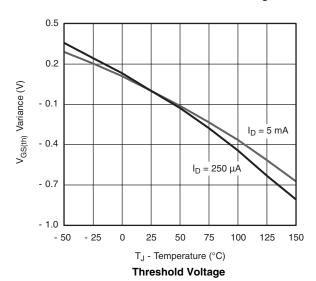
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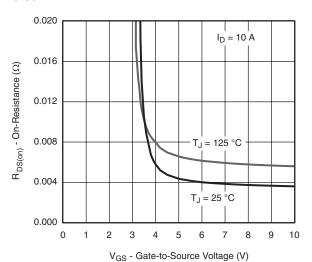
VISHAY

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

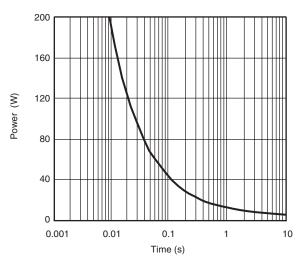


Source-Drain Diode Forward Voltage

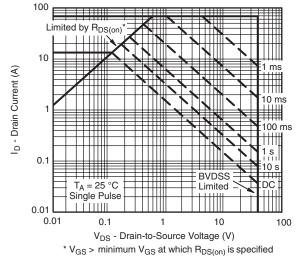




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power

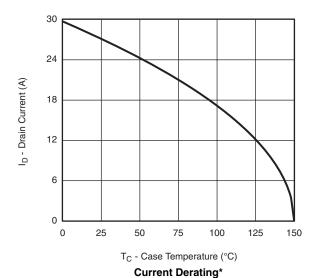


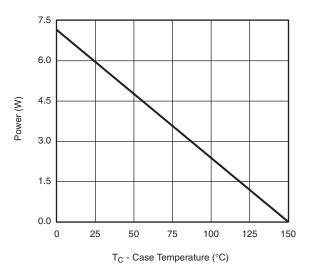
Safe Operating Area, Junction-to-Ambient



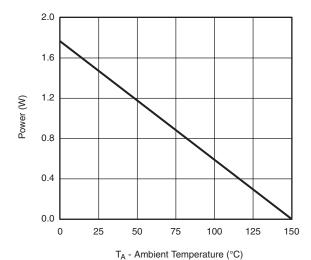
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





Power Derating, Junction-to-Foot



Power, Junction-to-Ambient

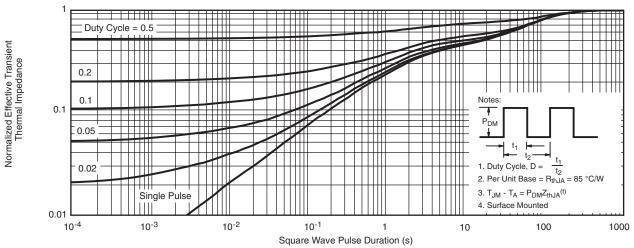
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

Si4122DY

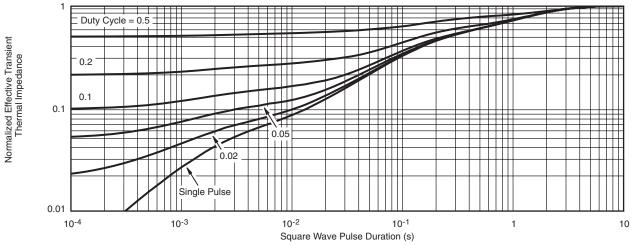
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?68665.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
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DWG: 5498

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RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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